

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/540,587	PIETRZYK, ANDRZEJ	
Examiner		Art Unit		Page 1 of 1
NIKHIL SRIRAMAN		3664		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,210,821 A	05-1993	Yazaki et al.	700/248
*	B	US-6,233,502 B1	05-2001	Yim, Mark H.	700/245
*	C	US-2002/0115373 A1	08-2002	Lazerman, Leon	446/85
*	D	US-6,459,957 B1	10-2002	Bennett et al.	700/245
*	E	US-6,487,454 B1	11-2002	Tymes, Adrian	700/2
*	F	US-6,477,444 B1	11-2002	Bennett et al.	700/245
*	G	US-6,510,359 B1	01-2003	Merkle et al.	700/121
*	H	US-6,636,781 B1	10-2003	Shen et al.	700/248
*	I	US-6,725,128 B2	04-2004	Hogg et al.	700/245
*	J	US-6,842,246 B2	01-2005	Roufas et al.	356/399
*	K	US-2005/0118925 A1	06-2005	Kretzschmar, Michael	446/124
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.